## Notice of References Cited Application/Control No. 10/580,059 Examiner VINH T. LAM Applicant(s)/Patent Under Reexamination ZHOU ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0196207 A1	12-2002	Machida et al.	345/55
*	В	US-6,531,997 B1	03-2003	Gates et al.	345/107
*	С	US-6,753,844 B2	06-2004	Machida et al.	345/107
*	D	US-6,822,783 B2	11-2004	Matsuda et al.	359/296
*	Е	US-7,057,600 B2	06-2006	Goden, Tatsuhito	345/107
*	F	US-7,342,556 B2	03-2008	Oue et al.	345/33
	G	US-			
	Н	US-			
	Ι	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Т					

## **NON-PATENT DOCUMENTS**

	NON-I ATENT BOOOMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	х							

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